

Cost Dynamics Across Pre-Silicon & Post-Silicon in Chip Productization



Chetan Arvind Patil
Contributing Writer | EPDT

Modern semiconductor product development, whether for consumer electronics, industrial control systems, or automotive platforms, depends on a structured productization flow that transitions a chip from design specification to volume manufacturing. This flow is divided into 2 primary stages - pre-silicon and post-silicon. Each phase plays a distinct role, engages different engineering domains and contributes uniquely to the overall development cost.

Pre-silicon encompasses architecture development, RTL implementation, design verification and physical design activities - all of which are performed in a virtual environment. Its goal is to ensure functional correctness, timing closure and testability before committing the design to fabrication. Post-silicon begins once the initial silicon samples are received - focusing on hardware bring-up, system-level validation, electrical characterisation, debugging, reliability testing and preparation for mass production.

The cost and risk profiles of these 2 phases are fundamentally different. In pre-silicon design, errors can often be resolved through simulation or emulation with relatively low incremental costs. However, issues uncovered in post-silicon, such as functional escapes, margin failures, or system-level anomalies, may require costly re-spins, extensive lab debugging and delayed product schedules.

These often require silicon re-spins, which not only incur high fabrication costs, but also introduce significant schedule delays. For

example, each silicon re-spin can cost upwards of millions of pounds, depending on the node and complexity of the change, and will typically add 8 to 12 weeks due to re-fabrication, validation and downstream re-qualification. Thus, understanding the technical scope and cost implications of both phases is crucial for optimising development budgets, mitigating risk, plus achieving performance, quality and reliability targets across various end markets.

Cost-critical activities across pre-silicon and post-silicon

The cost structure of silicon productization is directly influenced by the type and intensity of engineering functions performed across the pre-silicon and post-silicon phases. While both stages are essential, they contribute to development costs in different ways.

Pre-silicon activities drive fixed non-recurring engineering (NRE) costs, primarily through the use of EDA tools, compute infrastructure and verification efforts. These tasks, although expensive upfront, help identify bugs early - thereby allowing for faster and less disruptive fixes to the schedule. Post-silicon, in contrast, incurs variable and operational costs tied to lab infrastructure, ATE set-up and per-unit test development. Debug cycles are longer (due to reduced visibility in silicon) and late-stage bugs can trigger mask re-spins, delay production, or increase cost per part.

The breakdown shown in Table 1 highlights core activities in each phase that contribute directly to engineering workload and cost exposure.

In summary, the pre-silicon cost is primarily driven by simulation depth, tool licenses and compute demand, whereas the post-silicon cost scales with equipment, debug effort and risk containment. Understanding which activities drive cost and how they interact with design maturity helps teams to allocate resources strategically and reduces the likelihood of late-stage design failures.

Pre-Silicon (Design Phase)	Post-Silicon (Validation Phase)
Architecture definition and microarchitecture modelling.	Final design closure and tape-out risk review.
RTL development and logic verification using simulation and formal methods.	Debugging with limited internal visibility (scan chains, embedded logic analysers).
Functional coverage closure and assertion-based verification.	ATE test pattern validation, tuning and timing margin evaluation.
Emulation and FPGA prototyping for system-level use cases.	Parametric electrical characterisation (I/O levels, jitter, clock margins).
Static timing analysis (STA), synthesis and physical implementation.	Reliability and stress qualification (HTOL, burn-in, thermal cycling).
Design for test (DFT) architecture and automatic test pattern generation (ATPG) pattern generation for test coverage.	Yield analysis from production data and defect localisation.
Power, area and performance trade-off analysis.	Functional validation under corner conditions (PVT, aging, voltage droop).
Clock domain crossing (CDC) and reset domain crossing (RDC) verification.	Validation of safety and diagnostic features (especially for ISO 26262).
Hardware-software co-design and firmware boot flow simulation.	Validation with production-intent software and firmware.
IP integration and SoC-level netlist validation.	Regression validation across silicon lots and package variants.
Signoff checks (LVS, DRC, IR drop, EM, power grid integrity).	Customer-specific validation and compliance test execution.
Final design closure and tape-out risk review.	Silicon issue root cause analysis and ECO planning (if needed).

Table 1: Respective contributions of pre-silicon and post-silicon activities to overall expense and engineering resource allocation

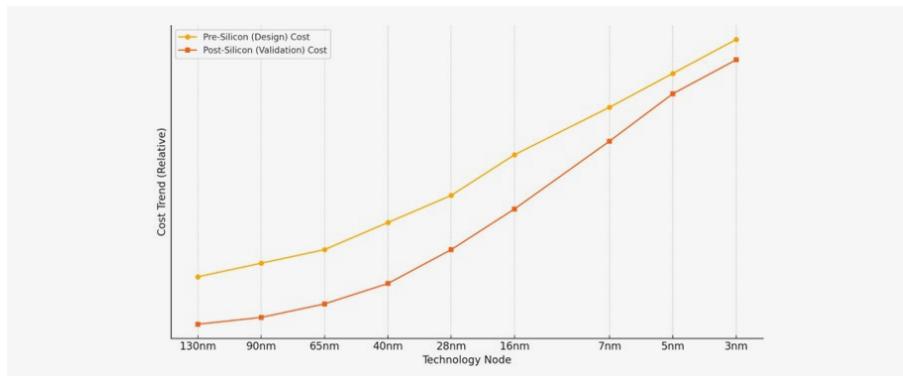


Figure 1: Closing the gap between design and validation across nodes [Note: This is a representation plot based on hypothetical data for illustrative purposes]

Closing the cost gap between pre-silicon and post-silicon

As silicon complexity increases and market timelines compress, the cost difference between pre-silicon and post-silicon phases is narrowing. Traditionally, pre-silicon absorbed the bulk of engineering effort and NRE costs through extensive design, simulation and verification activities. Post-silicon, while operationally expensive, was considered more manageable due to its structured debug and validation flow. This model is changing though.

Today, system-level interactions, power-performance trade-offs and software integration challenges are more complex to capture in pre-silicon fully. As a result, critical issues often surface only after the fabrication process is complete. A single post-silicon bug, if it necessitates a mask re-spin, can cost millions of pounds and delay product schedules by several months. The financial and strategic impact of such late-stage issues, including missed market windows, lost revenue and failure to meet customer qualification, can outweigh even the highest pre-silicon investments.

To address this, engineering teams are adopting a shift left strategy by moving validation, integration and analysis to earlier in the development cycle. This includes the widespread use of emulation and FPGA-based platforms to test full software stacks and corner-case scenarios before tape-out. Formal verification is applied to detect logic violations that the simulation might miss. Hardware-software co-design environments now allow for early firmware validation and performance modelling. In parallel, coverage-driven verification and analytics help measure and close functional gaps more effectively.

The goal is not to eliminate post-silicon cost, but to contain it. By investing more resources upfront, teams can detect system-level bugs earlier, thus reducing the need for silicon revisions and protecting project timelines. As advanced nodes drive up the cost of mistakes, pre-silicon effort is no longer a fixed cost. It is an active lever to reduce downstream risk and control total productization costs.

Strategies to balance pre-silicon and post-silicon costs

To conclude, effectively managing costs across pre-silicon and post-silicon phases requires more than understanding where money is spent. It calls for deliberate action to shift effort earlier, improve visibility downstream and make validation investment proportional to business risk. The following 6-step strategy offers a practical framework to help silicon design teams align design execution with validation towards optimised productization cost goals:

- Define cost-critical objectives - Align early decisions with downstream impact. Focus design and validation priorities on cost exposure points.
- Map verification scope to cost exposure
 - Utilise historical debug data and risk analysis to determine which bugs are more cost-effective to catch in simulation and which must be addressed post-silicon.
- Increase pre-silicon coverage efficiency
 - Leverage formal methods, emulation and scenario-driven validation to improve coverage without excessive simulation cost.
- Build post-silicon visibility into design - Plan for debugging, DFT and characterisation infrastructure upfront to reduce late-cycle effort and rework.
- Monitor validation effort in real time - Track simulation cycles, debug time and test cost as active metrics, not afterthoughts.
- Continuously feed learning into cost models - Use re-spin data, yield learning and debug effort to improve planning accuracy and reduce cost in future designs.

By embedding cost awareness into engineering decisions, this framework can help transform productization into a disciplined, forward-driven process that reduces re-spins, accelerates time-to-market and ensures competitive, high-quality silicon from the 1st pass. Today, silicon productization success is no longer just about design excellence - it is about making every engineering decision cost-aware, risk-aligned and validation-ready.

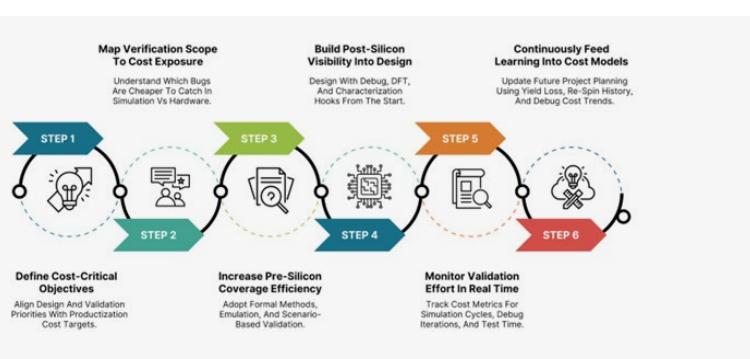


Figure 2: Strategic levers to balance pre-silicon and post-silicon costs